

Notice of References Cited	Application/Control No. 09/497,522	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
	Examiner Nhon T. Diep	Art Unit 2613	Page 1 of 1

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	B	US-5,767,922	06-1998	Zabih et al.	348/700
	C	US-6,778,697	08-2004	Shin et al.	382/164
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NON-PATENT DOCUMENTS

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